

# LINEAR SYSTEMS

Twenty-Five Years Of Quality Through Innovation

## 2N4351

N-CHANNEL MOSFET  
ENHANCEMENT MODE

### FEATURES

DIRECT REPLACEMENT FOR INTERSIL 2N4351

HIGH DRAIN CURRENT  $I_D = 20\text{mA}$

HIGH GAIN  $g_{fs} = 1000\mu\text{S}$

**ABSOLUTE MAXIMUM RATINGS<sup>1</sup>**  
@ 25 °C (unless otherwise stated)

#### Maximum Temperatures

Storage Temperature -55 to +150 °C

Operating Junction Temperature -55 to +150 °C

#### Maximum Power Dissipation, $T_A=25^\circ\text{C}$

Continuous Power Dissipation<sup>3</sup> 350mW

#### Maximum Current

Drain to Source 20mA

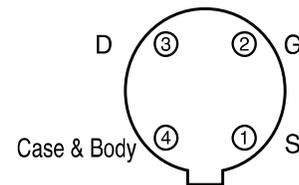
#### Maximum Voltages

Drain to Body 25V

Drain to Source 25V

Gate to Source  $\pm 30\text{V}$

TO-72  
TOP VIEW

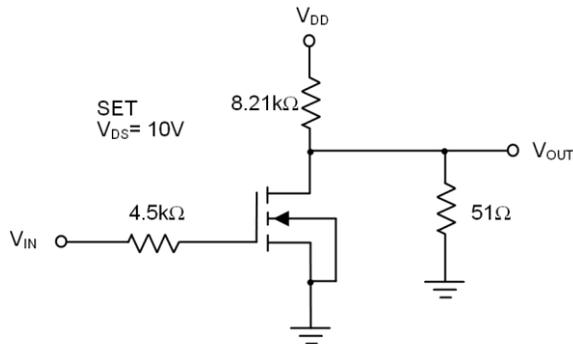


### ELECTRICAL CHARACTERISTICS @ 25 °C (unless otherwise stated) ( $V_{SB} = 0\text{V}$ unless otherwise stated)

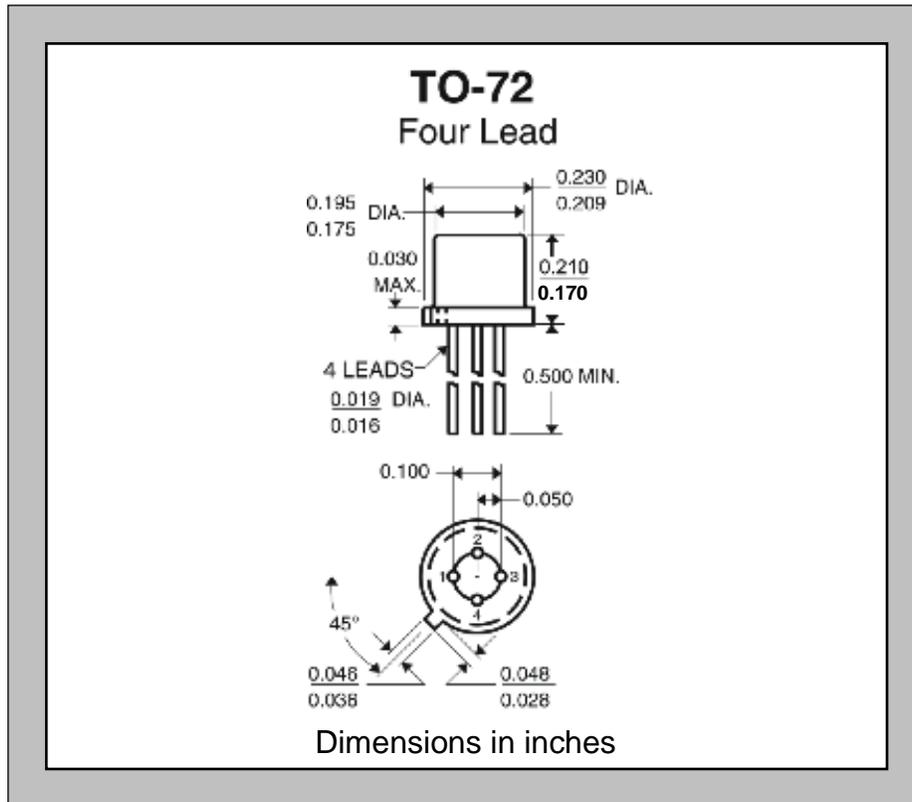
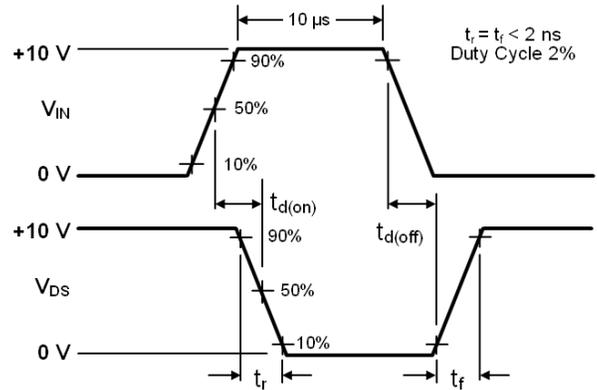
| SYMBOL       | CHARACTERISTIC                            | MIN  | TYP | MAX | UNITS         | CONDITIONS   |
|--------------|---|------|-----|-----|---------------|--|
| $BV_{DSS}$   | Drain to Source Breakdown Voltage         | 25   |     |     | V             | $I_D = 10\mu\text{A}, V_{GS} = 0\text{V}$                    |
| $V_{DS(on)}$ | Drain to Source "On" Voltage              |      |     | 1   |               | $I_D = 2\text{mA}, V_{GS} = 10\text{V}$                      |
| $V_{GS(th)}$ | Gate to Source Threshold Voltage          | 1    |     | 5   |               | $V_{DS} = 10\text{V}, I_D = 10\mu\text{A}$                   |
| $I_{GSS}$    | Gate Leakage Current                      |      |     | 10  | pA            | $V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$                |
| $I_{DSS}$    | Drain Leakage Current "Off"               |      |     | 10  | nA            | $V_{DS} = 10\text{V}, V_{GS} = 0\text{V}$                    |
| $I_{D(on)}$  | Drain Current "On"                        | 3    |     |     | mA            | $V_{GS} = 10\text{V}, V_{DS} = 10\text{V}$                   |
| $g_{fs}$     | Forward Transconductance                  | 1000 |     |     | $\mu\text{S}$ | $V_{DS} = 10\text{V}, I_D = 2\text{mA}, f = 1\text{MHz}$     |
| $r_{ds(on)}$ | Drain to Source "On" Resistance           |      |     | 300 | $\Omega$      | $V_{GS} = 10\text{V}, I_D = 100\mu\text{A}, f = 1\text{kHz}$ |
| $C_{rss}$    | Reverse Transfer Capacitance <sup>2</sup> |      |     | 1.3 | pF            | $V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 140\text{kHz}$  |
| $C_{iss}$    | Input Capacitance <sup>2</sup>            |      |     | 5.0 |               | $V_{DS} = 10\text{V}, V_{GS} = 0\text{V}, f = 140\text{kHz}$ |
| $C_{db}$     | Drain to Body Capacitance <sup>2</sup>    |      |     | 5.0 |               | $V_{DB} = 10\text{V}, f = 140\text{kHz}$                     |

| SYMBOL       | CHARACTERISTIC                   | MAX | UNITS |
|--------------|----------------------------------|-----|-------|
| $t_{d(on)}$  | Turn On Delay Time <sup>2</sup>  | 45  | ns    |
| $t_r$        | Turn On Rise Time <sup>2</sup>   | 65  |       |
| $t_{d(off)}$ | Turn Off Delay Time <sup>2</sup> | 60  |       |
| $t_f$        | Turn Off Fall Time <sup>2</sup>  | 100 |       |

#### SWITCHING TEST CIRCUIT



#### TIMING WAVEFORMS



1. Absolute maximum ratings are limiting values above which serviceability may be impaired.

Information furnished by Linear Integrated Systems is believed to be accurate and reliable. However, no responsibility is assumed for its use; nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Linear Integrated Systems.

2. Not a production test. Guaranteed by design.
3. Derate 2.8 mW °C above 25 °C.

Linear Integrated Systems (LIS) is a 25-year-old, third-generation precision semiconductor company providing high-quality discrete components. Expertise brought to LIS is based on processes and products developed at Amelco, Union Carbide, Intersil and Micro Power Systems by company President John H. Hall. Hall, a protégé of Silicon Valley legend Dr. Jean Hoerni, was the director of IC Development at Union Carbide, co-founder and vice president of R&D at Intersil, and founder/president of Micro Power Systems.